

April 1988 Revised September 2000

### 74F02

# **Quad 2-Input NOR Gate**

#### **General Description**

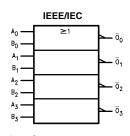
This device contains four independent gates, each of which performs the logic NOR function.

# **Ordering Code:**

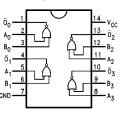
Order Number	Package Number	Package Description
74F02SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F02SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F02PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

# **Logic Symbol**



#### **Connection Diagram**



## **Unit Loading/Fan Out**

Pin Names	Deceriation	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>	
Pin Names	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>	
A <sub>n</sub> , B <sub>n</sub>	Inputs	1.0/1.0	20 μA/-0.6 mA	
$\overline{O}_n$	Outputs	50/33.3	−1 mA/20 mA	

#### **Absolute Maximum Ratings**(Note 1)

Storage Temperature -65°C to +150°C -55°C to +125°C

-30 mA to +5.0 mA

Ambient Temperature under Bias Junction Temperature under Bias  $-55^{\circ}C$  to  $+150^{\circ}C$ V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0V Input Voltage (Note 2) -0.5V to +7.0V

Input Current (Note 2) Voltage Applied to Output

in HIGH State (with  $V_{CC} = 0V$ )

Standard Output –0.5V to  $V_{\mbox{\footnotesize CC}}$ 3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated I<sub>OL</sub> (mA)

#### **Recommended Operating Conditions**

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

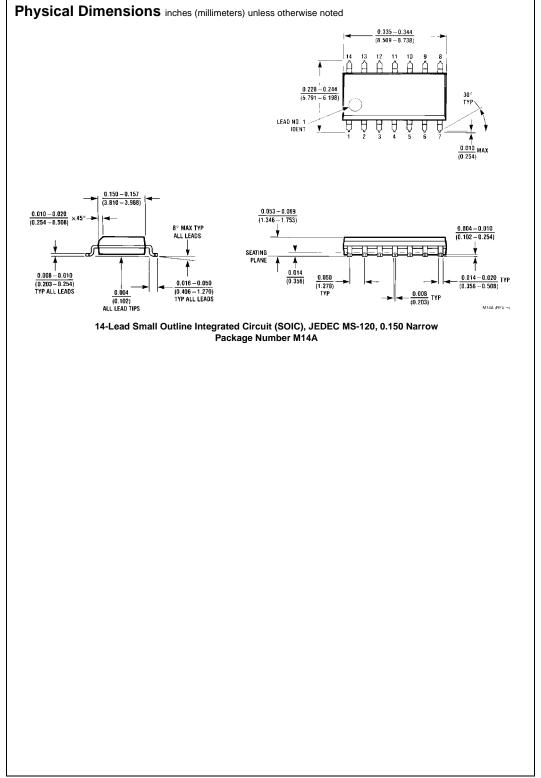
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

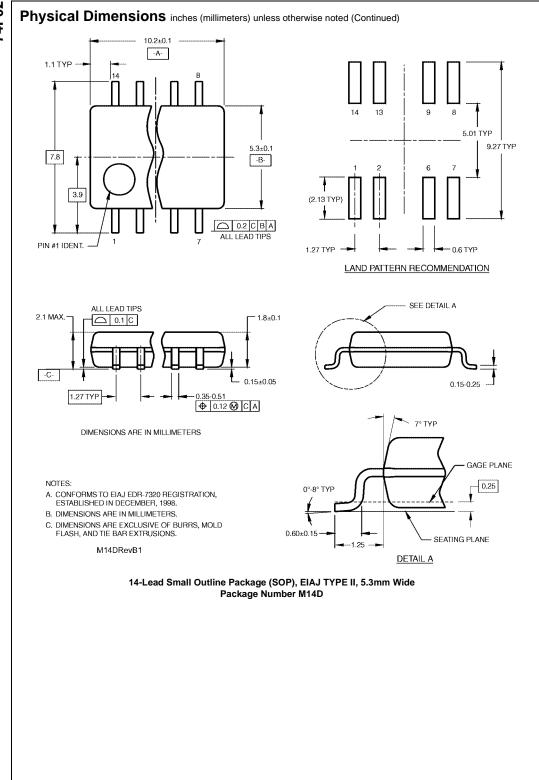
Symbol	Parameter Input HIGH Voltage		Min	Тур	Max	Units	v <sub>cc</sub>	Conditions	
V <sub>IH</sub>			2.0			V		Recognized as a HIGH Signal	
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V <sub>CD</sub>	Input Clamp Diode Voltage				-1.2	V	Min	I <sub>IN</sub> = -18 mA	
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.5			V	Min	I <sub>OH</sub> = -1 mA	
	Voltage	$5\% V_{CC}$	2.7			V	IVIIII	$I_{OH} = -1 \text{ mA}$	
V <sub>OL</sub>	Output LOW	10% V <sub>CC</sub>			0.5	V	Min	I <sub>OL</sub> = 20 mA	
	Voltage				0.5	V		I <sub>OL</sub> = 20 IIIA	
I <sub>IH</sub>	Input HIGH				5.0	μА	Max	V <sub>IN</sub> = 2.7V	
	Current				3.0	μΛ			
I <sub>BVI</sub>	Input HIGH Current				7.0	μА	Max	V <sub>IN</sub> = 7.0V	
	Breakdown Test	n Test			7.0	μΛ		VIN - 7.0 V	
I <sub>CEX</sub>	Output HIGH Leakage Current				50	μА	Max	V <sub>OUT</sub> = V <sub>CC</sub>	
					30			VOUT - VCC	
V <sub>ID</sub>	Input Leakage Test		4.75			٧	0.0	$I_{ID} = 1.9  \mu A$	
								All other pins grounded	
I <sub>OD</sub>	Output Leakage Circuit Current				3.75	μА	0.0	V <sub>IOD</sub> = 150 mV	
								All other pins grounded	
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$	
Ios	Output Short-Circuit Curre	ent	-60		-150	mA	Max	V <sub>OUT</sub> = 0V	
I <sub>CCH</sub>	Power Supply Current			3.7	5.6	mA	Max	V <sub>O</sub> = HIGH	
I <sub>CCL</sub>	Power Supply Current			8.7	13.0	mA	Max	$V_O = LOW$	

#### **AC Electrical Characteristics**

	Parameter	$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_A = -55^{\circ}C$	to +125°C	$T_A = 0$ °C to +70°C			
Symbol					$V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		V <sub>CC</sub> = +5.0V C <sub>L</sub> = 50 pF		Units	
		Min	Тур	Max	Min	Max	Min	Max		
t <sub>PLH</sub>	Propagation Delay	2.5	4.4	5.5	2.5	7.5	2.5	6.5	ns	
t <sub>PHL</sub>	$A_n$ , $B_n$ to $\overline{O}_n$	1.5	3.2	4.3	1.5	6.5	1.5	5.3	115	



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#### Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 - 0.770(18.80 - 19.56)0.090 (2.286) 14 13 12 11 10 9 8 14 13 12 0.250 ± 0.010 PIN NO. 1 IDENT PIN NO. 1 IDENT 1 2 3 4 5 6 7 1 2 3 $\frac{0.092}{(2.337)}$ DIA $\frac{0.030}{(0.762)}$ MAX OPTION 1 OPTION 02 $\frac{0.135 \pm 0.005}{(3.429 \pm 0.127)}$ 0.300 - 0.320 $\overline{(7.620 - 8.128)}$ 0.065 $\frac{0.145 - 0.200}{(3.683 - 5.080)}$ 0.060 4° TYP Optional (1.524) (1.651) $\frac{0.008 - 0.016}{(0.203 - 0.406)}$ TYP 0.020 (0.508) 0.125 - 0.150 $0.075 \pm 0.015$ $\overline{(3.175 - 3.810)}$ 0.280 (1.905 ± 0.381) (7.112) MIN 0.014 - 0.0230.100 ± 0.010 (2.540 ± 0.254) TYP (0.356 - 0.584) $\frac{0.050 \pm 0.010}{(1.270 - 0.254)} \text{ TYP}$ 0.325 <sup>+0.040</sup> -0.015 $8.255 + 1.016 \\ -0.381$

14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N14A

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N144 (REV.E)